

<b>Notice of References Cited</b>	Application/Control No. 10/781,826		Applicant(s)/Patent Under Reexamination CHAPMAN, MARK SETON	
	Examiner Gims S. Philippe		Art Unit 2621	Page 1 of 1

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*	B	US-2003/0002861	01-2003	Ichige et al.	386/117
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	K	US-			
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#### NON-PATENT DOCUMENTS

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